

MF SERIES 176 — Measuring Microscopes

- An easy-to-operate standard measuring microscope using specially designed long working distance ML objectives.
- Measuring accuracy is the highest in its class (and conforms to JIS B 7153).
- Illumination can be selected from an LED unit, which has a longer life, or a powerful halogen unit for high-magnification applications.
- Excellent usability, a high-NA and long working distance objectives enable effective observation.

Manual type

- Stages range in size from 100×100 mm to 400×200 mm.
- The XY stage is equipped with a quick-release mechanism that enables switching between coarse and fine feed to provide swift and precise stage movement, even over a large distance.



MF-B2017D

Note: The binocular tube (eyepiece) and illumination unit are optional accessories.

SPECIFICATIONS

Without Z-axis scale	Model No.	MF-A1010D	MF-A2010D	MF-A2017D	MF-A3017D	MF-A4020D	
WILLIOUT 7-9XI2 2C916	Order No.	176-861* ¹	176-862*1	176-863* ¹	176-864* ¹	176-865* ¹	
With Z-axis scale	Model No.	MF-B1010D	MF-B2010D	MF-B2017D	MF-B3017D	MF-B4020D	
WILLI Z-dXIS SCale	Order No.	176-866* ¹	176-867* ¹	176-868* ¹	176-869* ¹	176-870* ¹	
Observation image		BF (Bright-field)/Erect image					
Eyepiece with diopt	er adjustment	10X (eyepiece field number:	24), 15X, 20X Note: Monocu	lar - one 10X eyepiece provided a	as standard; Binocular - two 10X	eyepieces provided as standard	
Objective				ovided as standard), 1X, 5X,			
Illumination unit LED illumination unit (One of the two		Transmitted illumination: Telecentric system, Built-in aperture diaphragm, White LED light source, stepless light intensity control with cooling fan Reflected illumination: Koehler illumination, Variable aperture diaphragm mechanism, White LED light source, stepless light intensity control Control unit: Power ON/OFF switch (main switch), AC100 to 240 V power input connector					
options must be selected.) Transmitted illumination: Telecentric system, Built-in aperture diaphragm, Halogen bulb (50 W), stepless light intensity control unit: Power ON/OFF switch (main switch), AC100 to 240 V power input connector					ity control, With cooling fan nsity control, With cooling fan		
Measuring range		100×100 mm	200×100 mm	200×170 mm	300×170 mm	400×200 mm	
Stage	Quick-release mechanism	Provided as standard for the X and Y axes					
	Zero-set button	Provided as standard for the X and Y axes (and for the Z axis only for the MF-B type)					
Z axis	7 avis Max. workpiece height		150 mm 220 mm				
Feed mechanism		Coaxial coarse and fine feed, handles on both sides (coarse: 30 mm/rotation, fine: 0.2 mm/rotation)					
Measuring accuracy *2 (X and Y axes, when not loaded)		(2.2 + 0.02L) µm L=measuring length (mm)					
Resolution		1/0.5/0.1 μm 0.0001/0.00005/0.00001 in (switchable)					
Digital display	Display axes			or X, Y, and Z only for the M			
	Functions		Zero-setting, direction swit	ching, RS-232C output, USB	output (specific to QSPAK)		

- *1 The following suffixes are added to the order No.to specify the User Manual's language: -10 for English; -11 for Simplified Chinese; No suffix for Japanese.
- *2 Measuring method complies with JIS B 7153.

Motor-Driven Z-axis

- Freedom from burdensome focus adjustment even on a workpiece with many asperities allows the operator to perform stress-free measurement.
- Using the Vision Unit (optional) enables the image AF function.



Note: The binocular tube (eyepiece) and illumination unit are optional accessories.



Refer to the **MF/MF-U** Series Brochure (**E14003**) for more details.

SPECIFICATIONS for Motor-Driven Z-axis MF models

Model No.		MF-J2017D	MF-J3017D	MF-J4020D	
Order No.		176-891* ¹	176-892* ¹	176-893* ¹	
Vision AF *2		Available			
Ctago	Quick release mechanism		Fitted to X and Y axes		
Stage	Zero set switch		Fitted to X and Y axes		
Z axis	Max. workpiece height		220 mm		
Z dXI2	Feed mechanism	Motordrive	(Maximum measuring speed	l: 20 mm/s)	

^{*1} To denote your AC power cable add the following suffixes to the order No.: A for UL/CSA, D for CEE, DC for CCC, E for BS, K for KC, C and No suffix is required for PSE.

^{*2} Vision Unit and an image AF cable are separately required. Note: The specification other than the above is subject to the **MF** Series.



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MF-U SERIES 176 — Universal Measuring Microscopes

• Integration of metallurgical and measurement • Measuring accuracy is the highest in its class microscope functions provides high-resolution observation and a high-accuracy measurement solution.



- (and conforms to JIS B 7153).
- Illumination can be selected from an LED unit, which has a longer life, or a powerful halogen unit for high-magnification applications.
- Excellent usability, a high-NA and long working distance objectives enable effective observation.

Manual type

- Stages range in size from 100×100 mm to 400×200 mm.
- The XY stage is equipped with a quick-release mechanism that enables switching between coarse and fine feed to provide swift and precise stage movement, even over a large distance.



Refer to the MF/MF-U Series Brochure (E14003) for more details.

MF-UB2017D

Note: The turret, objectives and illumination unit are optional accessories.

SPECIFICATIONS

	Without	Model No.	MF-UA1010D	MF-UA2010D	MF-UA2017D	MF-UA3017D	MF-UA4020D	
BF	Z-axis scale	Order No.	176-871* ¹	176-872*1	176-873*1	176-874* ¹	176-875* ¹	
(Bright-field)	With	Model No.	MF-UB1010D	MF-UB2010D	MF-UB2017D	MF-UB3017D	MF-UB4020D	
	Z-axis scale	Order No.	176-876* ¹	176-877* ¹	176-878* ¹	176-879* ¹	176-880*1	
20	Without	Model No.	MF-UC1010D	MF-UC2010D	MF-UC2017D	MF-UC3017D	MF-UC4020D	
BD	Z-axis scale	Order No.	176-881* ¹	176-882* ¹	176-883*1	176-884*1	176-885* ¹	
(Bright-field/ Dark-field)	With	Model No.	MF-UD1010D	MF-UD2010D	MF-UD2017D	MF-UD3017D	MF-UD4020D	
Dark-Helu)	Z-axis scale	Order No.	176-886* ¹	176-887* ¹	176-888* ¹	176-889* ¹	176-890*1	
Observation ima	ge		BF (Bright-field), DF (D	ark-field) (MF-UC and MF-U	D models only), Polarization,	Differential Interference Cont	rast (DIC)/Erect image	
Eyepiece (option	al) with diopter	r adjustment		10X (eyepiece field numb	er: 24, two eyepieces provide	d as standard), 15X, 20X		
Turret (required)	Bright-field (BF			M	anual/Motor (select either on	۵)		
	Bright-field/da		· · · · · · · · · · · · · · · · · · ·					
Objective	Bright-field (BI	,	M Plan Apo, M Plan Apo HR, M Plan Apo SL, G Plan Apo					
(optional)	Bright-field/da	ark-tield (BD)	BD Plan Apo					
Illumination unit	LED illumination	on unit	Transmitted illumination: Telecentric system, Built-in aperture diaphragm, White LED light source, stepless light intensity control, With cooling far Reflected illumination: Koehler illumination, Variable aperture diaphragm mechanism, White LED light source, stepless light intensity control Control unit: Power ON/OFF switch (main switch), AC100 to 240 V power input connector					
options must be selected.)	Halogen illum	ination unit	Transmitted illumination: Telecentric system, Built-in aperture diaphragm, Halogen bulb (50 W), stepless light intensity control, With cooling fan Reflected illumination: Koehler illumination, Variable aperture diaphragm mechanism, 100 W or 150 W halogen bulb (selectable), external fiber-optic illumination, stepless light intensity control Control unit: Power ON/OFF switch (main switch), AC100 to 240 V power input connector					
	Measuring ran	ige	100×100 mm	200×100 mm	200×170 mm	300×170 mm	400×200 mm	
Stage	Quick-release	mechanism		Provid	ed as standard for the X and	Y axes		
-	Zero-set butto	n	Provided as standard for the X and Y axes (and for the Z axis only for the MF-UB and -UD types)					
Z axis	Max. workpied	ce height	150 mm 220 mm					
Z dXIS	Feed mechanis	sm	Coaxial coarse and fine feed, handles on both sides (coarse: 10 mm/rotation, fine: 0.1 mm/rotation)					
Measuring accur (X and Y axes, v	Measuring accuracy*2 (X and Y axes, when not loaded) (2.2 + 0.02L) μm L=measuring length (mm)							
	Resolution			1/0.5/0.1 μm	0.0001/0.00005/0.00001 i	n (switchable)		
Digital display	Display axes			X and Y (or X,	Y, and Z only for the MF-UB	and -UD types)		
. ,	Functions			Zero-setting, direction swit	ching, RS-232C output, USB of	output (specific to QSPAK)		

^{*1} The following suffixes are added to the order No.to specify the User Manual's language: -10 for English; -11 for Simplified Chinese; No suffix for Japanese.



^{*2} Measuring method complies with JIS B 7153.

Motor-Driven Z-axis

- Freedom from burdensome focus adjustment even on a workpiece with many asperities allows the operator to perform stress-free measurement.
- Using Vision Unit (optional) enables the image AF function.



Note: The turret, objectives and illumination unit are optional

SPECIFICATIONS for Motor-Driven Z-axis MF-U models

(Bright-field) Order No. 176-894*1 176-895*1	176-896* ¹				
BD Model No. MF-UK2017D MF-UK3017D	MF-UK4020D				
(Bright-field/Dark-field) Order No. 176-897 *1 176-898 *1	176-899* ¹				
Eyepiece (optional) with diopter adjustment 10X (eyepiece field number: 24, two eyepieces pro	ovided as standard), 15X, 20X				
Pright field (PE) M Dian Ano M Dian Ano HP M Dian A					
Objective (optional) Bright-field (BD) Bright-field (BD) BD Plan Apo BD Plan Apo	BD Plan Apo				
Vision AF* ² Available	Available				
Measuring range 200×170 mm 300×170 mm	400×200 mm				
Stage Quick release mechanism Fitted to X and Y axes	Fitted to X and Y axes				
Zero set switch Fitted to X and Y axes	Fitted to X and Y axes				
Z axis Max. workpiece height 220 mm	220 mm				
Feed mechanism Motor drive (measuring speed: ma	Motor drive (measuring speed: max. 20 mm/s)				
	(2.2 + 0.02L) µm L=measuring length (mm)				
Resolution 1/0.5/0.1 µm 0.0001/0.00005/0.000	1/0.5/0.1 μm 0.0001/0.00005/0.00001 in (switchable)				
Digital display Display axes X, Y and Z					
Functions Zero-setting, direction swit	tching				

^{*1} To denote your AC power cable add the following suffixes to the order No.: A for UL/CSA, D for CEE, DC for CCC, E for BS, K for KC, C and No suffix is required for PSE.

*2 Vision Unit and an image AF cable are separately required.

*3 Measuring method complies with JIS B 7153.

Note: For all specifications not included above see page J-7.



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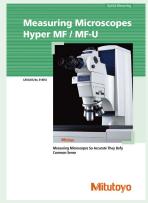
Hyper MF/MF-U SERIES 176 — High-Accuracy Measuring Microscopes

- Ultra-high accuracy measuring microscopes achieving $(0.9 + 3L/1,000) \mu m$ of accuracy.
- Three-axis motorized front operation joystick control, which makes a refreshing change from conventional microscope operation, allows fine positioning even during fast movement.
- Large workstage with stroke of 250×150 mm provides enough margin for the measurement of larger workpieces.
- The Vision Unit can be integrated to provide an effective and stable measurement environment.



Hyper MF-U

Note: The optical tube, turret, and objectives are optional.



Refer to the Hyper **MF/MF-U** Brochure (**E14012**) for more details.

SPECIFICATIONS

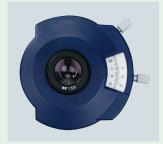
Model No.		HyperMF-B2515B	HyperMF-UB2515B	HyperMF-UD2515B	HyperMF-UE2515B	HyperMF-UF2515B			
Order No.		176-430*1	176-431* ¹	176-432*1	176-433*1	176-434*1			
Optical tube		Finite correction optical system BF (Bright-field)				Infinity-correction optical system BD (Bright/Dark-field) with the LAF function			
	Standard reticle (Built-in)			cross line (line width 5 µm)					
	Pupil distance adjustment			Adjustment range: 51 to 70					
	Optical path switching ratio		Observation/	FV-photomicrography=50/5	50				
	Vertical tilt angle	25°			Filting				
	TV port		Provided as standard						
Observation			Erect image						
Eyepiece	Magnification		10X, 15X, 20X						
Objective (optional)		Selectable from the monocular unit (equipped with one eyepiece) or binocular tube (equipped with two eyepieces)							
	ML Series objective	1X, 3X, 5X, 10X, 20X, 50X, 100X			_				
	BF (Bright-field)	_		M Plan Apo, M pla	an Apo SL, G plan Apo				
	BD (Bright/Dark-field)	_			Plan Apo				
Turret	BF (Bright-field)	_		ped with a four-hole manu					
(optional)	BD (Bright/Dark-field)	— (Equipped with a four-hole manual turret/motorized four-hole turret*3)							
Focusing	Maximum height of workpiece	150 mm							
section	Measuring accuracy		(1.5 + 10L/1000)	μm L=Measuring length	(mm)				
	Drive method			d control using a joystick					
Illumination		Telecentric system, Built-in aperture of							
unit	Reflected illumination unit	Koehler illumination, Variable aperture dia	phragm mechanism, Haloger		nt intensity control, Fiber-opt	ic cable cold light illumination			
Workstage	Measuring range (X×Y)			250×150 mm					
	Measuring accuracy*4 (When no load is put on the X or Y axis)	(0.9 + 3L/1000) µm L=Measuring length (mm)							
	Dimensions of the top plane			460×350 mm					
	Usable dimensions of the stage glass			300×200 mm					
	Swiveling angle	±3°							
	Maximum loading mass	30 kg							
	Drive method	Motorized control using a joystick							
Detector		High precision digital scale (Patented)							
Digital	Resolution			0.01 μm					
display	Axes to be displayed								
	Data processing unit		Vis	ion Unit (required)					
Operation	LAF (just focus)	_	-	_	A	vailable			
section	LAF (tracking focus)	_	-	_	A	vailable			

^{*1} To denote your AC power cable add the following suffixes to the order No.: A for UL/CSA, D for CEE, DC for CCC, E for BS, K for KC, C and No suffix is required for PSE. *2 and *3 are factory-installed options. *4 Measurement accuracy complies with JIS B 7153.



MeasurLink® ENABLED

Angle Index (Standard Accessory)



TM **SERIES 176 — Toolmakers' Microscopes**

- Compact universal toolmakers' microscope that can be installed on any site.
- Newly designed LED illuminators provide enhanced observation for higher accuracy and resolution.
- Optional LED circular illuminator available for applications requiring all-round lighting.
- Achieves a maximum measuring height of 115 mm despite the compact size.
- Installation of Digimatic micrometer heads (164-163, optional) makes measurement easy and precise.
- A vernier scale (Angle Index) built into the eyepiece mount enables accurate angular measurements.
- Lenses are available for a wide range of magnifications (20X to 200X in total).





Note: Micrometer heads are optional.

SPECIFICATIONS

Model No.		TM-505B	TM-1005B			
Order No.		176-818	176-819			
Optical tube		Monocular type (Vertical tilt angle: 30°)				
Observation	image	Ero	ect			
Eyepiece pro	tractor	Resolution (graduation): 1°, Rotation angle: 36	O°, Resolution (angle): 6', Adjustable zero point			
Eyepiece		Standard accessory: 15X (field r	number: 13), Options: 10X, 20X			
Objective		Standard accessory: 2	2X, Optional: 5X, 10X			
Microscope	Maximum height of workpiece	115 mm	107 mm			
head Focusing method		Manual (C	oarse feed)			
Illumination Transmitted illumination		Stepless brightness adjustment, White LED light source with green filter				
unit Reflected illumination		Oblique single-source type, Stepless brightness adjustment, White LED light source				
	Measuring range	50×50 mm	100×50 mm (An optional 50 mm gauge block is required to cover full range. A CERA block is recommended.)			
Cross-travel	Table size	152×152 mm	240×152 mm			
stage	Usable area of the stage glass	96×96 mm	154×96 mm			
Maximum stage glass loading		5 kg				
Linear measurement method		Micrometer head*				
Resolution		Depends on the micrometer head specifications* (for 164-163 : 0.001 mm)				
Micrometer I	nead travel range		63 : 50 mm			
Power supply	1	AC100 to 240 V 50/60 Hz Maxi	mum power consumption: 4.2 W			
Main unit ma	ass	14 kg	15 kg			
* Micromater heads are entional for TM-505R and TM-1005R						

* Micrometer heads are optional for **TM-505B** and **TM-1005B**.

Note: The main unit with Digimatic micrometer head (**164-164**) is provided in the **TM** Series. **TM-A505B** (**176-820A**)

TM-A1005B (176-821A)
Other specifications are the same as the other TM Series.





Refer to the **TM** Series Brochure (E14013) for more details.



MeasurLink® ENABLED Data Management Software by Mitutoyo

Vision Unit SERIES 359 — Vision System Retrofit for Microscopes

- The measurement tools and various macro icons allow measurement in one easy step.
- The graphics and measurement navigation functions facilitate operation.
- The image saving function and the data output function to the spreadsheet software are standard.
- Combined use with the **MF/MF-U** Series (Motor-Driven Z-axis) achieves the image AF (auto focus) function.



Foot switch 12AAJ088



MF-J2017D plus Vision Unit

SPECIFICATIONS

Model	Vision Unit
Order No.	359-763
Magnification of the optical system	When installed on the microscope 0.5X (using the 0.5X TV adapter)
Image detection	High-sensitivity 1/2 inch color CMOS camera 3 megapixel
Resolution	0.1 µm
Accuracy (Measurement environment: 20 °C)	Depends on the accuracy specification of the Mitutoyo measuring microscope to which the unit is fitted. For reference: When using an ML Series 3X objective (In an inspection using a sample workpiece based on the Mitutoyo standards) Measurement accuracy in the screen: Within ±2.5 µm Repetitive accuracy in the screen (±2 \(\sigma\)): Within ±1 µm
Software (optional)	QSPAK VUE

Note: Software (**QSPAK VUE**) and calculation processor are required separately.

Applicable Models

Mitutoyo MF Series, MF-U Series, Hyper MF Series, Hyper MF-U Series



Refer to the **QM-Data200** and Vision Unit Brochure (**E14008**) for more details.





QM-Data200 **SERIES 264 — 2D Data Processing Unit**

- 2D Data Processor designed to perform arithmetic processing of XY coordinate data acquired from projectors and measuring microscopes for local display or output to a
- Informative color-graphic displays on the large LCD screen make for easy measurement operations.

Mitutoyo

- The AI measurement function (automatic identification of measuring item) eliminates switching between the measurement command keys.
- Equipped with a measurement procedure teaching function and measuring position navigation in Repeat mode.
- The user menu function allows users to register measurement commands or part programs to create their own menus.
- Measurement result output to CSV format in spreadsheet software.
- Measurement procedures and calculation results can be saved on a USB-compatible memory device.



12AAJ088

SPECIFICATIONS

QM-Data200 (stand type)

Model No.	QM-Data200					
Order No.	Stand type	Flexible arm type	Stand type			
Order No.	264-155* ¹	264-156* ¹	264-159*1			
Applicable models (Conventional models)*2	PJ-PLUS Series PJ-H30 Series PV-5110 PH-3515F MF Series MF-U Series	PJ-PLUS Series PJ-H30 Series PV-5110* ³ PH-3515F* ³	Hyper MF/MF-U			
Unit of measurement	3	vitchable between decimal degree				
Resolution	0.1	II.	0.01 μm			
Program function		orming, and editing of measureme				
Statistical processing	Number of data, maximum value, minimum value, mean value, standard deviation, range, histogram, Statistics classified by each measurement function (Statistics classified by each command)					
Display unit	Color graphic LCD (equipped with LED backlight)					
ABS point	_	Available (Automatic movement)				
LAF (Laser AF)	_	Available				
Edge sensor position correction	Available (Profile Projectors with OPTOEYE 200) —					
Input/output	XYZ: Data input from linear scales (Maximum number of axes: 3) RS-232C 1: Connection to an external PC RS-232C 2: Connection to a measuring unit counter OPTOEYE: Connection to an OPTOEYE edge signal (OPTOEYE 200) FS: For the connection to the foot switch PRINTER: For the connection to an external printer USB-MEMORY: For the connection to a USB memory					
Measurement result file output		RS-232C output (CSV format, MUX-10 format)				
Display language	16 languages (Japanese, English, German, French, Italian, Spanish, Portuguese, Czech, Chinese (simplified/traditional), Korean, Turkish, Swedish, Polish, Dutch, Hungarian)					
Power supply	AC100 to 240 V					
Maximum power consumption	17 W (excluding optional accessories)					
External dimensions (WxHxD)	260×242×310 mm (including the stand section)	318×153×275 mm (when the arm is horizontal)	260×242×310 mm (including the stand section)			
Mass	Approx. 2.9 kg	Approx. 2.8 kg	Approx. 2.9 kg			
Standard Accessories	AC ada	pter, Power cable, Quick Operation	n Guide			
1 To depote your AC power cable add the following cuffives to the order No : A for III /CSA D for CEE E for DS K for KC C and						

^{*1} To denote your AC power cable add the following suffixes to the order No.: A for UL/CSA, D for CEE, E for BS, K for KC, C and No suffix is required for PSE, and 00 for power cord other than A, D, E, K, C, No suffix.

*2 Please contact Mitutoyo sales office with respect to the models that are applicable to the models other than mentioned above.

*3 The flexible arm type cannot be used concurrently with a counter stand.



Refer to the QM-Data200 and Vision Unit Brochure (E14008) for more details.



FS70 SERIES 378 — Microscope Unit for Semiconductor Inspection

- Compact microscope unit equipped with an eyepiece observation section.
- Can be used with YAG (near-infrared, visible, near-ultraviolet, or ultraviolet) lasers.*1
 - *1 The performance and safety of laser-equipped system products is not guaranteed.
- Usable in infrared optical systems*². Applications: observation of silicon wafers; spectral characteristics analysis using infrared. *2 An infrared source and infrared camera are necessary.
- Models supporting BF (Bright-field), DF (Dark-field), Polarization, and Differential Interference Contrast (DIC) are available.
- The inward-facing turret and long working distance objectives maintain the high operability of the microscope.



Refer to the Microscope Units and Objectives Brochure (**E14020**) for more details.



Note: The parfocal manual turret, eyepieces and objectives are optional.

SPECIFICATIONS

Standard	Model No.	FS70	_	FS70Z	_	FS70ZD	FS70L	FS70L4
head type	Order No.	378-184-1	_	378-185-1	_	Made-to-order	378-186-1	378-187-1
Tilting	Model No.	_	FS70-TH	_	FS70Z-TH	FS70ZD-TH	FS70L-TH	FS70L4-TH
head type	Order No.	_	378-184-3	_	378-185-3	Made-to-order	378-186-3	378-187-3
Focus adjus	us adjustment 50 mm travel range with concentric coarse (3.8 mm/rev) and fine (0.1 mm/rev) focusing wheels (right/left)							
					Erect image			
	BF (Bright-field)	V	✓	~	~		~	V
Observation	BD (Bright- field/Dark-field)					~		
image	Polarization	V	✓	~	~	~	✓	~
	Differential Interference Contrast (DIC)	V	V	~	~	V		
Optical tube type Siedentopf, adjustable interpupillary distance ra			e range: 51 to 76 mm					
Field number 24 mm								
Tilt angle		0 to 20°, displacement of eye point: 114 mm (only for tilting head type)						
Optical pass	s ratio	Fixed type (Eyepiece/TV= 50/50)	Switchable type (Eyepiece/Tube= 100/0: 0/100)	Fixed type (Eyepiece/TV= 50/50)	Switchable type (Eyepiece/Tube= 100/0: 0/100)	Fixed type*1 (Eyepiece/TV= 50/50)	Switchable type (Eyepiece/Tube= 100/0: 0/100)	
Protective fi	ilter			_		1	Built-in lase	r beam filter
Tube lens		1.	X		1X to 2X zoom		1	X
Applicable I	laser			_			1064/532/355 nm	532/266 nm
Camera mo	ount		C-mou	nt (using optional adap	ter B* ²)		Use a laser with TV port.	C-mount receptacle (with green filter switch)
Optical syste	Optical system epi-illumination Epi-illumination for Bright-field (Koehler illumination, with aperture diaphragm)			ragm)				
Illumination	nination unit (optional) Fiber-optic illumination unit (100 W), stepless adjustment, light guide length: 1.5 m							
	Objective, optional (for observation) M Plan Apo/HR/SL, G Plan Apo BD Plan Apo			M Plan Apo/HR	/SL, G Plan Apo			
	Objective, optional (for laser-cutting)			NIR Series NUV Series	UV Series			
Loading*3		14.5 kg	13.6 kg	14.1 kg	13.2 kg	14.1 kg (tilting head type: 13.2 kg)	14.2 kg (tilting head type: 13.5 kg)	13.9 kg (tilting head type: 13.1 kg)
Mass (main	unit)	6.1 kg	7.1 kg	6.6 kg	7.5 kg	6.6 kg (tilting head type: 7.5 kg)	6.4 kg (tilting head type: 7.2 kg)	6.7 kg (tilting head type: 7.5 kg)

^{*1} It is a switchable type when using **FS70ZD-TH** (Tilting head type).

[·] Check the mass of the laser source. When mounting on a high-speed device or acceleration/deceleration device, please contact us.



^{*2} Installation is optional.

^{*3} Loading on optical tube excluding weight of objectives and eyepieces

Note: Observe the following precautions when using **FS70L** or **FS70L4** with YAG laser source attached.

[·] Be aware of the laser power and energy density limitations of the optical system to avoid damage.

- Compact and lightweight microscope designed to be built in for camera observation
- · Can be used with YAG (near-infrared, visible, near-ultraviolet, or ultraviolet)
- *1 The performance and safety of laser-equipped system products is not guaranteed.
- For VMU-LB and VMU-L4B, the rigidity and general performance of the microscope main unit have been enhanced compared with previous models.
- Compatible with infrared optical systems*²
- *2 An infrared source and infrared camera are necessary.

VMU SERIES 378 — Microscope unit for incorporating in Equipment

• Telecentric system equipped with an aperture diaphragm is standard on the epi-illumination optical system.

• Best suited to process images for which uniform illumination is required.









Design and manufacture are flexible to meet your

SPECIFICATIONS

Model No. VMU-V		VMU-H	VMU-LB	VMU-L4B		
Order No.		378-505	378-506	378-513	378-514	
Camera mounting direction		Vertical	Vertical Horizontal		Vertical (Rotatable)	
Observati	on	Bright-field/Erect image	Bright-field/Inverted image	Bright-field	Erect image	
	TV adapter		Equipped with a C-mount		Equipped with a C-mount (Equipped with a green filter switching mechanism)	
Optical tube	Image forming (tube) lens	Built-in 1X (visible/nea	Built-in 1X (visible/near-infrared calibration)		Built-in 1X (ultraviolet/visibility compensation)	
tube	Available for lasers	_	_		YAG laser source (Second/Third/Fourth harmonic) mountable	
	For observation	M	l Plan Apo, M Plan Apo HF	R, M Plan Apo SL, G Plan A	ро	
Objective (optional)		-	_	NIR Series NUV Series Note 1: Selected depending on the wavelength of the laser source	NIR Series NUV Series UV Series Note 2: Selected depending on the wavelength of the laser source	
Applicable	e camera (s)		2/3 type or less can	neras (C-mount type)		
Optical sy epi-illumi						
Illuminated lens tube		Bright-field illuminated lens tube				
Illuminatio	n unit (optional)		Fiber-optic cable illuminat	ion unit (100 W) (378-700)		
Main unit	mass	650 g	750 g	1270 g	1300 g	
Maria S. Th	NA DI A	AV . I. S of the State of the Alberta		270 745\		

Note 3: The M Plan Apo 1X objective is used with the polarization unit (378-710 or 378-715).

Mitutoyo

Refer to the Microscope Units and Objectives Brochure (E14020) for more details.

- Observation over a wide field of view (Image field of ø30 mm)
- Greatly enhanced brightness on the periphery of the field of view (Reduces the dependence on the light distribution characteristics.)
- Compatible with infrared optical systems*
- * An infrared source and infrared camera are necessary. For more details on infrared observation, contact your local Mitutoyo sales office.
- Small optical observation system
- Compatible with **HR** series of high resolving power lens (Designed with pupil diameter of ø16.8 mm)
- Available for various observation methods (Including bright-field, dark-field for visual or scratch inspection, and polarized observation of objects with polarization characteristics)



Bright-field Infrared Dark-field

WIDE VMU







WIDE VMU-BDV



WIDE VMU-BDH

SPECIFICATIONS

U-BDH 518 ntal				
-				
ntal				
iitui				
rk-field / image				
nt				
ø30				
Mountable				
less (equivalent to APS-C format)				
illumination nination) urce on-off				
itable) * ³				
g				
ir				

^{*1} Polarized observation by Bright-field illumination *2 Support for third-party LED illuminators (WIDE VMU-HR only)

*3 The fiber (light source) mount orientation can be changed.

FS Objectives

SERIES 378 — Ultra-long working distance Objectives

- M/BD Plan Apo (M Plan Apochromat Bright/ Dark-field) objectives feature the image evenness over the entire view field needed to achieve high color reproducibility.
- The following objectives support a wide range of wavelength including near infrared, visible, and ultraviolet lasers. Specialty LCD laser objectives are available: NIR (-HR) Series (Nearinfrared lenses for laser processing featuring
- ultra-long working distances), **NUV** Series (Near-ultraviolet lenses), **UV** Series (Ultraviolet lenses), and **G Plan Apo** (Cover Glass corrected lenses that allow focusing through a window for vacuum and high temperature applications).
- Uses environment-friendly glass (no lead or arsenic) for the lens material.

BF (Bright-field) for observation/measurement



For near-ultraviolet calibration (NUV)



BD (Bright/Dark-field) for observation/measurement

For the ultraviolet calibration (UV)



For near-infrared calibration (NIR)





Refer to the Microscope Units and Objectives Brochure (E14020) for more details.

Varifocal Lens **TAGLENS**

- Without changing the required magnification, ultra-high speed variable focal length enables obtaining perfectly focused images in real-time with stress-free operation.
- The time required for auto-focusing is drastically reduced, and the optical system focus range is extended without the expense of a mechanical drive.

TAGLENS-T1

Ultra-high speed, varifocal lens.

A dedicated controller and software are equipped as standard.

SPECIFICATIONS

Operating principle	Variable refraction index	
Resonance frequency	70 kHz	
Effective aperture	ø11 mm*	
Transmittance	90% or more (λ400 to 700 nm)*	

^{*} The above value are based on optical design theoretically.

Video Microscope Unit VMU-T1

Microscope unit for configuring a varifocal optical system by incorporating **TAGLENS-T1**, the objective and the camera.

SPECIFICATIONS

Compatible TAGLENS	TAGLENS-T1
Imaging lens magnification	1X
Imaging area	ø11 mm
Applicable objective	M Plan Apo Series
Options	Manual turret, Power turret, Polarizer, Focusing unit A or B, XY stage, Simplified stand.

M Plan Apo Series

in rian 7,50 Series								
Objectiv	/e	1X	2X	5X	7.5X	10X	20X	50X
Depth o	of focus×2 (mm)	0.88	0.18	0.028	0.012	0.007	0.003	0.0018
Total sca	anning width (mm)	16	4.0	0.64	0.28	0.16	0.04	0.007
Real FOV	1/2 inch camera	4.8×6.4	2.4×3.2	0.96×1.28	0.64×0.85	0.48×0.64	0.24×0.32	0.096×0.128
(mm)	2/3 inch camera	6.6×8.8	3.3×4.4	1.32×1.76	0.88×1.17	0.66×0.88	0.33×0.44	0.132×0.176

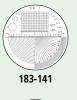




Refer to the Varifocal Lens **TAGLENS** Brochure (E14025) for more details.



Optional Reticles for pocket comparators

























Mini Scope SERIES 183

• Portable and easy to carry. Provides 25X magnification for high-resolution observation.



SPECIFICATIONS

Magnification	Order No.	Remarks
25X	183-210	Pen type

Note: Not compatible with the interchangeable reticles.

Pocket Comparators SERIES 183

• By replacing optional reticles, dimensional, angle, and other types of measurement can be performed.



183-140

SPECIFICATIONS

Magnification	Order No.	Remarks
10X	183-140	Optional reticles available

Clear Loupe SERIES 183

• Three magnification options selectable according to your application.







183-312

SPECIFICATIONS

Magnification	Order No.	Remarks
5X	183-310	Drawtube removable
10X	183-311	Drawtube removable
15X	183-312	Drawtube removable

Note: Not compatible with the interchangeable reticles.



Microscopes

Numerical Aperture (NA)

The NA figure is important because it indicates the resolving power of an objective. The larger the NA value the finer the detail that can be seen. A lens with a larger NA also collects more light and will normally provide a brighter image with a narrower depth of focus than one with a smaller NA value.

$$NA = n \cdot Sin \theta$$

The formula above shows that NA depends on n, the refractive index of the medium that exists between the front of an objective and the specimen (for air, n=1.0), and angle θ , which is the half-angle of the maximum cone of light that can enter the lens.

Resolving Power (R)

The minimum detectable distance between two image points, representing the limit of resolution. Resolving power (R) is determined by numerical aperture (NA) and wavelength (λ) of the illumination.

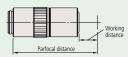
$$R = \frac{\lambda}{2 \cdot NA} \; (\mu m) \qquad \lambda = 0.55 \; \mu m \; \text{is often used as the reference wavelength}$$

Working Distance (W.D.)

The distance between the front end of a microscope objective and the surface of the workpiece at which the sharpest focusing is obtained.

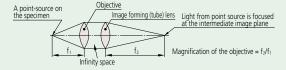
Parfocal Distance

Distance between the surface of the specimen and the objective's seating surface when in focus.



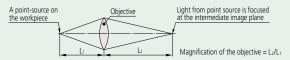
Infinity-corrected Optical System

An optical system in which the image is formed by an objective and a tube lens with an 'Infinity Space' between them, into which optical accessories can be inserted.



Finite-corrected Optical System

An optical system in which the image is formed only by an objective.



Focal Length (f)

unit: mr

The distance from the principal point to the focal point of a lens: if f1 represents the focal length of an objective and f2 represents the focal length of an image forming (tube) lens then magnification is determined by the ratio between the two. (In the case of the infinity-correction optical system.)

Objective magnification = $\frac{\text{Focal length of the image-forming (tube) lens}}{\text{Focal length of the objective}}$ $\text{Example: } 1X = \frac{200}{200}$ $\text{Example: } 10X = \frac{200}{20}$

Focal Point

Light rays traveling parallel to the optical axis of a converging lens system and passing through that system will converge (or focus) to a point on the axis known as the rear focal point, or image focal point.

Depth of Focus (DOF)

unit: mm

This is the distance (measured in the direction of the optical axis) between the two planes which define the limits of acceptable image sharpness when the microscope is focused on an object. As the numerical aperture (NA) increases, the depth of focus becomes shallower, as shown by the expression below:

DOF (
$$\mu m$$
) = $\frac{\lambda}{2 \cdot (NA)^2}$ λ = 0.55 μm is often used as the reference wavelength

Example: For an **M Plan Apo 100X** lens (NA = 0.7) The depth of focus of this objective is $\frac{0.55 \ \mu m}{2 \times 0.7^2} = 0.6 \ \mu m$

Bright-field and Dark-field Illumination

In bright-field illumination a full cone of light is focused by the objective on the specimen surface. This is the normal mode of viewing with an optical microscope. With dark-field illumination, the inner area of the light cone is blocked so that the surface is only illuminated by light from an oblique angle. Dark-field illumination is good for detecting surface scratches and contamination.

Apochromat and Achromat Objectives

An apochromat objective is a lens corrected for chromatic aberration (color blur) in three colors (red, green, blue). An achromat objective is a lens corrected for chromatic aberration in two colors (red, blue).

Magnification

The ratio of the size of a magnified object image created by an optical system to that of the object. Magnification commonly refers to lateral magnification although it can mean lateral, vertical, or angular magnification.

Principal Ray

A ray considered to be emitted from an object point off the optical axis and passing through the center of an aperture diaphragm in a lens system.

Aperture Diaphragm

An adjustable circular aperture which controls the amount of light passing through a lens system. It is also referred to as an aperture stop and its size affects image brightness and depth of focus.

Field Stop

An aperture which controls the field of view in an optical instrument.

Telecentric System

An optical system where the light rays are parallel to the optical axis in object and/or image space. This means that magnification is nearly constant over a range of working distances, therefore almost eliminating perspective error.

Erect Image

An image in which the orientations of left, right, top, bottom and moving directions are the same as those of a workpiece on the workstage.

Field number (FN), real field of view, and monitor display magnification unit mm

The observation range of the sample surface is determined by the diameter of the eyepiece's field stop. The value of this diameter in millimeters is called the field number (FN). In contrast, the real field of view is the range on the workpiece surface when actually magnified and observed with the objective. The real field of view can be calculated with the following formula:

(1) The range of the workpiece that can be observed with the microscope (diameter)

Real field of view = $\frac{FN \text{ of eyepiece}}{Objective magnification}$

Example: The real field of view of a 10X lens is $2.4 = \frac{24}{10}$

(2) Monitor observation range

Monitor observation range = $\frac{\text{The size of the camera image sensor(Length} \times \text{Height)}}{\text{Objective magnification}}$

	,				
Size of image	Format	Diagonal length	Length	Height	
sensor	1/3 in	6.0	4.8	3.6	
	1/2 in	8.0	6.4	4.8	
	2/3 in	11.0	8.8	6.6	

(3) Monitor display magnification

Monitor display magnification =

Objective magnification \times $\frac{\text{Display diagonal length on the monitor}}{\text{Diagonal length of camera image sensor}}$